INTEGRATED CIRCUITS

DATA SHEET

74LVT534

3.3 V Octal D-type flip-flop; inverting (3-State)

Product data Supersedes data of 1998 Feb 19





3.3 V Octal D-type flip-flop, inverting (3-State)

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FEATURES

- 3-State outputs for bus interfacing
- Common output enable
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- No bus current loading when output is tied to 5 V bus
- Power-up 3-State
- Power-up reset
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

DESCRIPTION

The LVT534 is a high-performance BiCMOS product designed for V_{CC} operation at 3.3 V.

This device is an 8-bit, edge triggered register coupled to eight 3-State output buffers. The two sections of the device are controlled independently by the clock (CP) and Output Enable ($\overline{\text{OE}}$) control gates. The state of each D input (one set-up time before the LOW-to-HIGH clock transition) is transferred to the corresponding flip-flop's Q output.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors. The active-LOW Output Enable (\overline{OE}) controls all eight 3-State buffers independent of the clock operation.

When $\overline{\text{OE}}$ is LOW, the stored data appears at the outputs. When $\overline{\text{OE}}$ is HIGH, the outputs are in the high-impedance "off" state, which means they will neither drive nor load the bus.

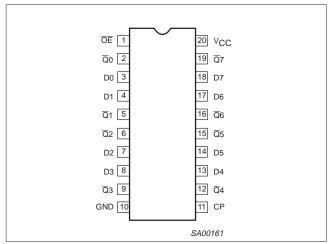
QUICK REFERENCE DATA

SYMBOL	PARAMETER	PARAMETER CONDITIONS $T_{amb} = 25 ^{\circ}\text{C}$; GND = 0 V				
t _{PLH} t _{PHL}	Propagation delay CP to Qn	$C_L = 50 \text{ pF};$ $V_{CC} = 3.3 \text{ V}$	3.0 3.5	ns		
C _{IN}	Input capacitance	$V_{I} = 0 \text{ V or } 3.0 \text{ V}$	4	pF		
C _{OUT}	Output capacitance	Outputs disabled; V _{I/O} = 0 V or 3.0 V	7	pF		
I _{CCZ}	Total supply current	Outputs disabled; V _{CC} = 3.6 V	0.13	mA		

ORDERING INFORMATION

STEP ET STEP STEP STEP STEP STEP STEP ST			
PACKAGES	TEMPERATURE RANGE	TYPE NUMBER	DWG NUMBER
20-Pin Plastic SOL	−40 °C to +85 °C	74LVT534D	SOT163-1
20-Pin Plastic SSOP Type II	−40 °C to +85 °C	74LVT534DB	SOT339-1
20-Pin Plastic TSSOP Type I	-40 °C to +85 °C	74LVT534PW	SOT360-1

PIN CONFIGURATION



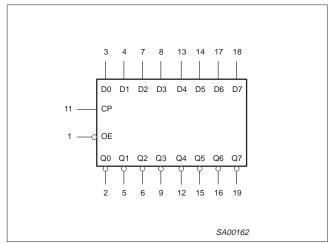
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1	ŌĒ	Output enable input (active-LOW)
3, 4, 7, 8, 13, 14, 17, 18	D0 to D7	Data inputs
2, 5, 6, 9, 12, 15, 16, 19	Q0 to Q7	Inverting 3-State outputs
11	СР	Clock pulse input (active rising edge)
10	GND	Ground (0 V)
20	V _{CC}	Positive supply voltage

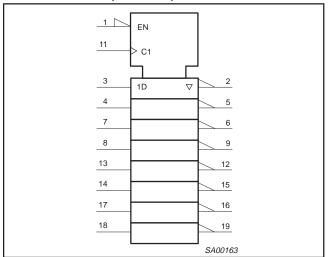
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LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



FUNCTION TABLE

	NPUT	3	INTERNAL	OUTPUTS	OPERATING
OE	СР	Dn	REGISTER	Q0 to Q7	MODE
L L	\uparrow	l h	L H	H L	Latch and read register
L	1	Х	NC	NC	Hold
H H		X Dn	NC Dn	Z Z	Disable outputs

H = HIGH voltage level

HIGH voltage level one set-up time prior to the LOW-to-HIGH

clock transition

LOW voltage level

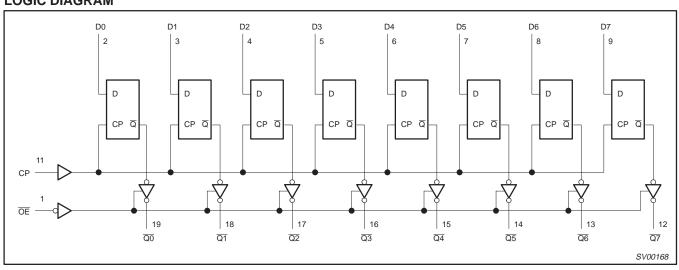
LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition

No change

Don't carehigh-impedance "off" state

LOW-to-HIGH clock transition not a LOW-to-HIGH clock transition

LOGIC DIAGRAM



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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V _I < 0 V	-50	mA
V _I	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0 V	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or HIGH state	-0.5 to +7.0	V
	DC output outroot	Output in LOW state	128	A
Гоит	DC output current	Output in HIGH state	-64	mA
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction

temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	ITS	UNIT
STIMIBOL	FARAMETER	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.7	3.6	V
VI	Input voltage	0	5.5	V
V _{IH}	HIGH-level input voltage	2.0	-	V
V_{IL}	Input voltage	_	0.8	V
I _{OH}	HIGH-level output current	_	-32	mA
,	LOW-level output current	-	32	A
l _{OL}	LOW-level output current; current duty cycle ≤ 50 %, f ≥ 1 kHz	-	64	mA
Δt/Δν	Input transition rise or fall rate; outputs enabled	_	10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

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DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} =	UNIT		
			MIN	TYP ¹	MAX	1	
V _{IK}	Input clamp voltage	$V_{CC} = 2.7 \text{ V; } I_{IK} = -18 \text{ mA}$		-	-0.9	-1.2	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V; } I_{OH} = -100 \mu\text{A}$		V _{CC} - 0.2	V _{CC} - 0.1	-	V
V_{OH}	HIGH-level output voltage	V _{CC} = 2.7 V; I _{OH} = -8 mA		2.4	2.5	-	V
		$V_{CC} = 3.0 \text{ V; } I_{OH} = -32 \text{ mA}$		2.0	2.2	-	V
		$V_{CC} = 2.7 \text{ V}; I_{OL} = 100 \mu\text{A}$		-	0.1	0.2	V
		V _{CC} = 2.7 V; I _{OL} = 24 mA		-	0.3	0.5	V
V_{OL}	LOW-level output voltage	V _{CC} = 3.0 V; I _{OL} = 16 mA		-	0.25	0.4	V
		V _{CC} = 3.0 V; I _{OL} = 32 mA	-	0.3	0.5	V	
		V _{CC} = 3.0 V; I _{OL} = 64 mA		-	0.4	0.55	V
V _{RST}	Power-up output low voltage ⁵	$V_{CC} = 3.6 \text{ V}; I_O = 1 \text{ mA}; V_I = \text{GND or } V_O$	-	0.13	0.55	V	
		V _{CC} = 0 V or 3.6 V; V _I = 5.5 V		-	1	10	μΑ
	land balana aman	$V_{CC} = 3.6 \text{ V}; V_I = V_{CC} \text{ or GND}$	Control pins	-	± 0.1	± 1	μΑ
t _l	Input leakage current	V _{CC} = 3.6 V; V _I = V _{CC}	5	-	0.1	1	μΑ
		V _{CC} = 3.6 V; V _I = 0 V	Data pins ⁴	-	-1	- 5	μΑ
I _{OFF}	Output off current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 0 \text{ V to } 4.5 \text{ V}$		-	1	± 100	μΑ
		V _{CC} = 3 V; V _I = 0.8 V	75	150	-	μΑ	
I _{HOLD}	Bus Hold current A inputs ⁷	V _{CC} = 3 V; V _I = 2.0 V		-75	-150	-	μΑ
		V _{CC} = 0 V to 3.6 V; V _{CC} = 3.6 V		± 500	-	-	μΑ
I _{EX}	Current into an output in the HIGH state when V _O > V _{CC}	V _O = 5.5 V; V _{CC} = 3.0 V		-	60	125	μА
I _{PU/PD}	Power-up/down 3-State output current ³	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V to } V_{CC}; V_I = GIOE/OE = Don't care$	ND or V _{CC} ;	-	1	± 100	μΑ
I _{OZH}	3-State output HIGH current	V_{CC} = 3.6 V; V_{O} = 3 V; V_{I} = V_{IL} or V_{IH}		-	1	5	μΑ
I _{OZL}	3-State output LOW current	V_{CC} = 3.6 V; V_{O} = 0.5 V; V_{I} = V_{IL} or V_{IH}		-	1	- 5	μΑ
I _{CCH}		$V_{CC} = 3.6 \text{ V}$; Outputs HIGH; $V_I = \text{GND}$ ($I_O = 0 \text{ mA}$	or V _{CC} ;	-	0.13	0.19	mA
I _{CCL}	Quiescent supply current ³	$V_{CC} = 3.6 \text{ V}$; Outputs LOW, $V_I = \text{GND o}$ $I_O = 0 \text{ mA}$	or V _{CC} ;	-	3	12	mA
I _{CCZ}		$V_{CC} = 3.6 \text{ V}$; Outputs Disabled; $V_I = GN$ $I_O = 0 \text{ mA}^6$	ID or V _{CC} ;	-	0.13	0.19	mA
Δl _{CC}	Additional supply current per input pin ²	V_{CC} = 3 V to 3.6 V; One input at V_{CC} – Other inputs at V_{CC} or GND	0.6 V;	-	0.1	0.2	mA

- All typical values are at V_{CC} = 3.3 V and T_{amb} = 25 °C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.
 This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 msec. From V_{CC} = 1.2 V to V_{CC} = 3.3 V ± 0.3 V a transition time of 100 μsec is permitted. This parameter is valid for T_{amb} = 25 °C only.
 Unused pins at V_{CC} or GND.
- For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
 I_{CCZ} is measured with outputs pulled to V_{CC} or down to GND.
 This is the bus hold overdrive current required to force the input to the opposite logic state.

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AC CHARACTERISTICS

GND = 0 V; t_R = t_F = 2.5 ns; C_L = 50 pF; R_L = 500 Ω ; T_{amb} = -40 °C to +85 °C.

					LIMITS			UNIT ns ns
SYMBOL	PARAMETER	WAVEFORM	Vcc	; = 3.3 V ± 0).3 V	V _{CC} =	ns ns	
			MIN	TYP ¹	MAX	MIN	MAX	
f _{MAX}	Maximum clock frequency	1	100	150	_	100	-	ns
t _{PLH} t _{PHL}	Propagation delay CP to Qn	1	1.7 2.2	3.0 3.5	4.6 4.9	- -	5.4 5.2	ns
t _{PZH} t _{PZL}	Output enable time to HIGH and LOW level	3 4	1.7 1.7	3.2 3.3	5.4 5.5	- -	7.0 5.6	ns
t _{PHZ}	Output disable time from HIGH and LOW level	3 4	2.1 2.1	3.5 3.4	4.8 4.8	_ _	5.3 4.6	ns

NOTE:

AC SETUP REQUIREMENTS

GND = 0 V; t_R = t_F = 2.5 ns; C_L = 50 pF; R_L = 500 Ω ; T_{amb} = -40 °C to +85 °C.

				LIMITS	3	
SYMBOL	PARAMETER	WAVEFORM	V_{CC} = 3.3 V \pm 0.3 V		V _{CC} = 2.7 V	UNIT
			MIN	TYP	MIN	
t _S (H) t _S (L)	Setup time, HIGH or LOW, Dn to CP	2	2.0 2.6	1.0 1.3	2.0 3.2	ns
t _H (H) t _H (L)	Hold time, HIGH or LOW, Dn to CP	2	0	-1.3 -0.9	0 0	ns
t _W (H) t _W (L)	CP pulse width HIGH or LOW	1	1.5 4.2	0.8 3.0	1.5 5.0	ns

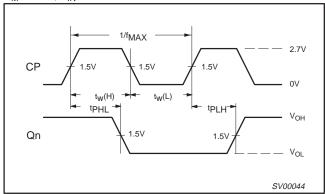
^{1.} All typical values are at V_{CC} = 3.3 V and T_{amb} = 25 $^{\circ}C.$

3.3 V Octal D-type flip-flop, inverting (3-State)

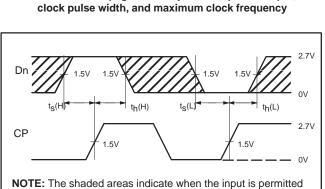
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AC WAVEFORMS

 $V_M = 1.5 \text{ V}, V_{IN} = \text{GND to } 2.7 \text{ V}$



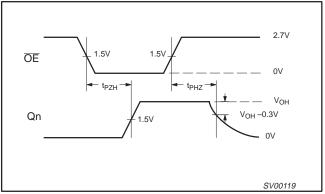
Waveform 1. Propagation delay, clock input to output, clock pulse width, and maximum clock frequency



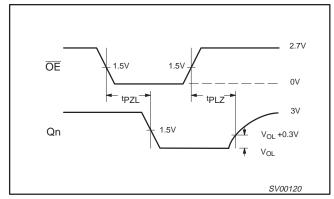
Waveform 2. Data setup and hold times

SV00108

to change for predictable output performance.



Waveform 3. 3-State Output Enable time to HIGH level and Output Disable time from HIGH level

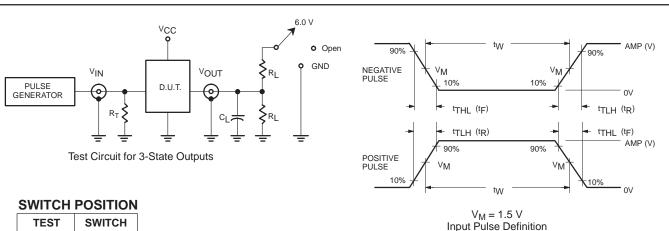


Waveform 4. 3-State Output Enable time to LOW level and Output Disable time from LOW level

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TEST CIRCUIT AND WAVEFORM



TEST	SWITCH
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	6V
t _{PHZ} /t _{PZH}	GND

DEFINITIONS

R_L = Load resistor; see AC CHARACTERISTICS for value.

 $R_T = -$ Termination resistance should be equal to Z_{OUT} of pulse generators.

FAMILY	IN	PUT PULSE R	EQUIRE	MENTS	
	Amplitude	Rep. Rate	t _W	t _R	t _F
74LVT	2.7 V	≤10 MHz	500 ns	≤2.5 ns	≤2.5 ns

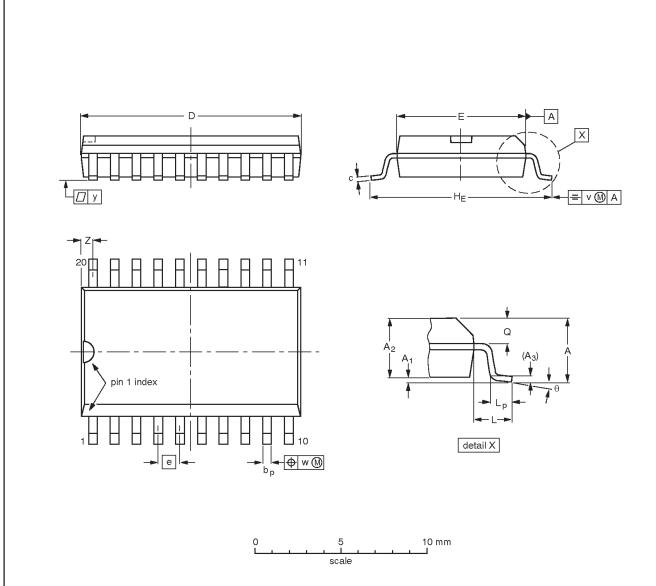
SV00092

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SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	2.65	0.3 0.1	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.1	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.05	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

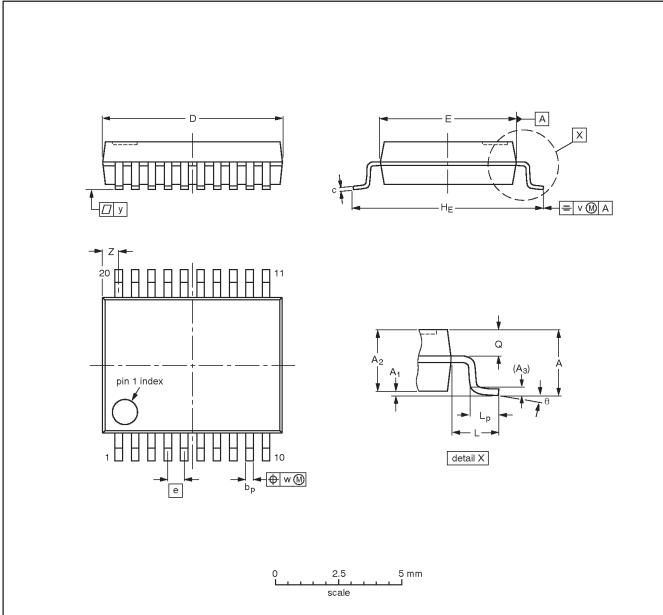
OUTLINE		EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT163-1	075E04	MS-013			-99-12-27 03-02-19	

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SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1



DIMENSIONS (mm are the original dimensions)

UNI	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	7.4 7.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.9 0.5	8° 0°

Note

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

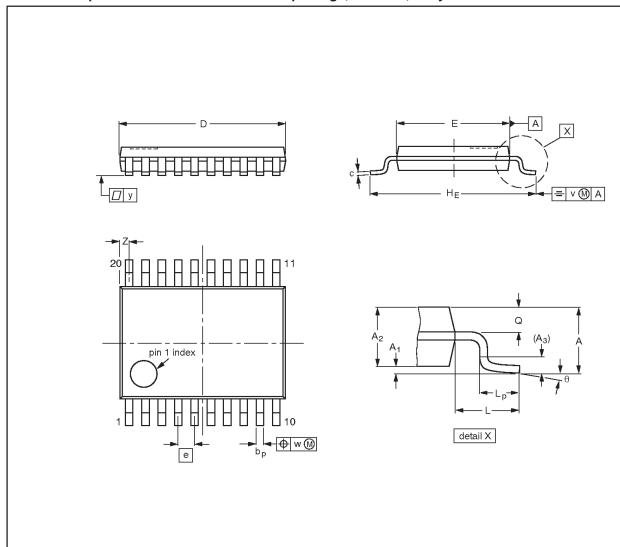
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VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT339-1		MO-150				99-12-27 03-02-19	

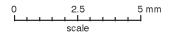
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TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1





DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bp	O	D ⁽¹⁾	E ⁽²⁾	ψ	HE	L	Lp	œ	٧	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	6.6 6.4	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFEF	EUROPEAN	ICCUE DATE			
VERSION	VERSION IEC		JEITA		PROJECTION	ISSUE DATE	
SOT360-1		MO-153				-99-12-27 03-02-19	

3.3 V Octal D-type flip-flop, inverting (3-State)

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REVISION HISTORY

Rev	Date	Description
_3	20040825	Product data sheet (9397 750 14004). Supersedes Product specification of 1998 Feb 19 (9397 750 03536).
		Modifications:
		Ordering information table on page 2: - remove 'North America' column change polymp handing 'Outside North America' to 'Type Number'.
		change column heading 'Outside North America' to 'Type Number'
		AC characteristics table on page 6: change Max. value of t _{PHZ} from '3.0 ns' to '4.8 ns'
_2	19980219	Product specification (9397 750 03536). ECN 853-1855 18988 of 19 February 1998. Supersedes data of 1996 Aug 13.
_1	19960813	

3.3 V Octal D-type flip-flop, inverting (3-State)

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Data sheet status

Level	Data sheet status ^[1]	Product status ^[2] [3]	Definitions
I	Objective data sheet	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data sheet	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data sheet	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

^[1] Please consult the most recently issued data sheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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^[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

^[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.